

DT15 Rec'd PCT/PTO 24 SEP 2004

Sheet 1 of 1

Based on Form PTO-1449 (3/90)	ATTY. DOCKET NO. 450100-04403	SERIAL NO. 10/509203 Filed Concurrently Herewith
	APPLICANT Takuya KITAMURA	
	FILING DATE Filed Concurrently Herewith	GROUP 2624

LIST OF REFERENCES CITED BY APPLICANT
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
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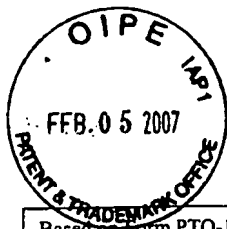
FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
/E.Y./	AL	JP 10-75370	03/17/98	Japan			
/E.Y./	AM	JP 6-332667	12/02/94	Japan			
/E.Y./	AN	JP 6-54208	02/25/94	Japan			
/E.Y./	AO	JP 5-207287	08/13/93	Japan			
/E.Y./	AP	JP 4-156794	05/29/92	Japan			
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OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
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Sheet 1 of 1

Based on Form PTO-1449 (3/90) LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	ATTY. DOCKET NO. 450100-04403	SERIAL NO. 10/509,203
	APPLICANT Takuya KITAMURA	
	FILING DATE September 24, 2004	GROUP 2624

U.S. PATENT DOCUMENTS							
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
/E.Y./	AL	4 156794	05/29/92	Japan			YES
/E.Y./	AM	4 233373	08/21/92	Japan			YES
/E.Y./	AN	10 75370	03/17/98	Japan			YES
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	APPLICANT Takuya KITAMURA	
	INT'L FILING DATE March 14, 2003	GROUP 2624

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U.S. PATENT DOCUMENTS							
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
/E.Y./	AL	WO 96/28937	09/19/96	PCT			
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